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## Erratum: Quality concerns caused by quality control — deformation of silicon strip detector modules in thermal cycling tests

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Due to a typesetting oversight, a correction is missing from the original paper:

- Table 1: the correct entry for thickness of the silicon sensor is “305-335  $\mu\text{m}$ ”. See the correct table below.

**Table 1.** Module component dimensions for endcap and barrel variants [3].

Component	Material	Thickness
Sensor	Silicon	305-335 $\mu\text{m}$
Hybrids (Endcap)	Copper, Polyimide	240-285 $\mu\text{m}$
Hybrids (Barrel)	Copper, Polyimide	378-462 $\mu\text{m}$
Powerboard (Endcap)	Copper, Polyimide	218-322 $\mu\text{m}$
Powerboard (Barrel)	Copper, Polyimide	385 $\mu\text{m}$

## References

[1] ...

[2] ...

[3] ITK STRIP MODULES group, *QC: Metrology procedures — modules*, presented at the *Czech ATLAS ITk Strip group status report*, Prague, Czech Republic, November 21 (2021).